**Product data sheet** 

## 1. General description

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and Integrated NTC temperature sensor, configured with Pressfit pin and pre-applied thermal paste.



## 2. Features and benefits

- · Half bridge topology
- PressFit pins technology
- · Pre-applied thermal interface material
- Low R<sub>DSon</sub>
- Low Switching Losses
- Low Q<sub>q</sub> and C<sub>rss</sub>
- Low Inductive Design
- · Integrated with NTC temperaure sensor

## 3. Applications

- Auxiliary Inverters
- DC-DC converters
- Automotive Applications
- · Hybrid Electrical Vehicles (H)EV

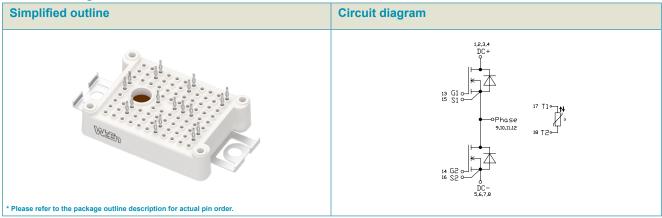
## 4. Quick reference data

### Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit	
Absolute maximum rating								
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C			1200		V	
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C			145		А	
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> = 25 °C			278		W	
$T_{j.op}$	operating junction temperature			-40 to 150			°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit	
Static cha	aracteristics							
$R_{\text{DS(on)}}$	drain-source on-state	$V_{GS} = 15 \text{ V}; I_D = 100 \text{ A}; T_j = 25 \text{ °C}$		-	10	-	mΩ	
	resistance	V <sub>GS</sub> = 18 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 25 °C		-	8.3	14	mΩ	
Dynamic	characteristics			,				
Q <sub>G(tot)</sub>	total gate charge	$I_D = 100 \text{ A}$ ; $V_{DS} = 800 \text{ V}$ ; $V_{GS} = -4 \text{ V}/18 \text{ V}$ ;		-	402	-	nC	
$Q_{GD}$	gate-drain charge	T <sub>j</sub> = 25 °C		-	62	-	nC	
Source-drain diode								
Q <sub>r</sub>	recovered charge	$I_{SD}$ = 100 A; $V_{GS}$ = -4 V; di/dt = 6500 A/ $\mu$ s; $V_{R}$ = 600 V; $T_{j}$ = 25 °C		-	950	-	nC	

# 5. Pinning information

### **Table 2. Pinning information**



## 6. Ordering information

## **Table 3. Ordering information**

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WMSC010H12B1L	WeEnPACK-B1	WMSC010H12B1L6T	Tray	24	WeEnPACK- B1PHB-B	11-Feb-2025

# 7. Marking

## Table 4. Marking codes

Type number	Marking codes
WMSC010H12B1L	WMSC010H12B1L

# 8. Limiting values

### **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
T <sub>stg</sub>	storage temperature			-40 to 125	°C
$T_{j.op}$	operating junction temperature			-40 to 150	°C
$T_{j.max}$	maximum junction temperature	Intermittent condition with shortened lifetime		-40 to 175	°C
V <sub>ISOL</sub>	RMS isolation voltage	T <sub>j</sub> = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s		3500	V
MOSFET					
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		1200	V
$V_{\rm GS,max}$	gate-source voltage	Absolute maximum values		-12 to 24	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		-4 to 18	V
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> = 25 °C		278	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C		145	Α
		V <sub>GS</sub> = 18 V; T <sub>h</sub> = 100 °C		92	Α
I <sub>DM</sub>	peak drain current	pulse width $t_p$ limited by $T_{jmax}$	Fig.17	290	Α
E <sub>as</sub>	single pulse drain-to- source avalanche	$I_{AS}$ = 30 A; L = 1 mH; $V_{DD}$ = 100 V; $T_{j(init)}$ = 25 °C; per MOSFET		450	mJ
Body Diod	le				
I <sub>SD</sub>	DC body diode forward current	V <sub>GS</sub> = -4 V; T <sub>h</sub> = 25 °C		60	А
I <sub>SD,pulse</sub>	Pulse body diode current	verified by design, $t_p$ limited by $T_{jmax}$		290	Α
	<u> </u>				

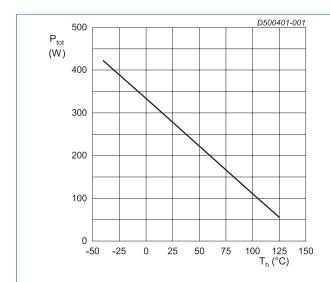


Fig. 1. Power dissipation as a function of heatsink temperature; maximum values

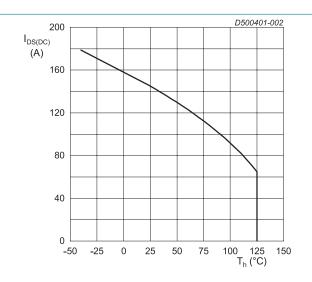


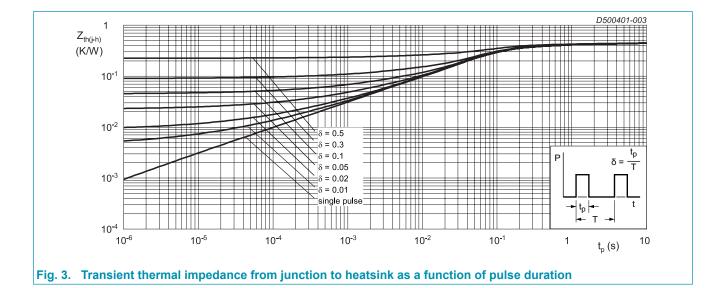
Fig. 2. Continuous Drain Current as a function of heatsink temperature

## 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-c)}}$	thermal resistance from junction to case	per MOSFET		-	0.30	-	K/W
$R_{\text{th(j-h)}}$	thermal resistance from junction to heatsink	per MOSFET, valid with pre-applied thermal interface material, λgrease = 4 W/(m·K), thickgrease= 120 μm		-	0.45	-	K/W
Internal Is	solation	basic insulation (class 1, IEC 61140)			$Al_2O_3$		
d <sub>Creep</sub>	Creepage distance	terminal to heatsink		-	11.5	-	mm
		terminal to terminal		-	6.3	-	mm
d <sub>Clear</sub>	Clearance	terminal to heatsink		-	10	-	mm
		terminal to terminal		-	5	-	mm
CTI	Comperative tracking index				>200		
F	Mounting force per clamp			20	-	50	N
G	Approximate Weight			-	20	-	g

Note: Module is ESD sensitive. Handling precautions are recommended.

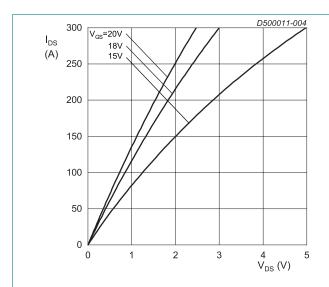


## 10. Characteristics

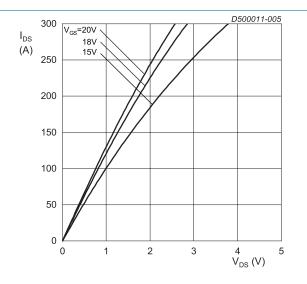
### **Table 7. Characteristics**

MOSFET							
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
	aracteristics		I		1		
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 200 \mu A; V_{GS} = 0 V; T_j = 25 °C$		1200	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold	$I_D = 40 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}$		1.9	2.5	3.5	V
	voltage	$I_D = 40 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 175 \text{ °C}$		-	1.9	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 1200 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	0.4	200	μA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 24 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	20	200	nA
	(absolute value)	V <sub>GS</sub> = -12 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	20	200	nA
R <sub>DS(on)</sub>	drain-source on-state	V <sub>GS</sub> = 15 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 25 °C		-	10	-	mΩ
	resistance	V <sub>GS</sub> = 18 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 25 °C		-	8.3	14	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 125 °C		-	11.7	-	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 150 °C		-	13.2	-	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 175 °C		-	13.9	-	mΩ
$R_{\scriptscriptstyle G}$	gate resistance, each side	$f$ = 1 MHz; $T_j$ = 25 °C, each die with 4.7 $\Omega$ $R_{G(ext)}$ in series		-	2.7	-	Ω
g <sub>fs</sub>	transconductance	V <sub>DS</sub> = 20 V; I <sub>D</sub> = 100 A; T <sub>j</sub> = 25 °C		-	56	-	S
Dynamic	characteristics						
Q <sub>G(tot)</sub>	total gate charge $I_D = 100 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$			-	402	-	nC
$Q_{GS}$	gate-source charge	$T_j = 25 ^{\circ}\text{C}$		-	170	-	nC
$Q_{GD}$	gate-drain charge			-	62	-	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 1000 V; V <sub>GS</sub> = 0 V; f = 100 KHz;		-	9	-	nF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C		-	405	-	pF
C <sub>rss</sub>	reverse transfer capacitance			-	26	-	pF
E <sub>oss</sub>	Coss stored energy			-	203	-	μJ
$t_{d(on)}$	turn-on delay time	V <sub>DS</sub> = 800 V; V <sub>GS</sub> = -4 V/18 V;		-	29	-	ns
t <sub>r</sub>	rise time	$R_{G(off)} = 2.4 \Omega$ ; $R_{G(on)} = 2.4 \Omega$ ; $I_D = 100 A$ ; $L = 130 \mu H$ ; $T_i = 25 °C$		-	13	-	ns
$t_{\text{d(off)}}$	turn-off delay time			-	84	-	ns
t <sub>f</sub>	fall time			-	40	-	ns
E <sub>on</sub>	turn-on energy			-	2.3	-	mJ
E <sub>off</sub>	turn-off energy			-	0.82	-	mJ

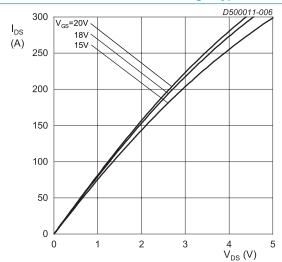
Body dio	de						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$V_{\text{SD}}$	source-drain voltage	$V_{GS}$ = -4 V; $I_{SD}$ = 100 A; $T_j$ = 25 °C		-	5.5	-	V
		$V_{GS} = -4 \text{ V}; I_{SD} = 100 \text{ A}; T_j = 150 ^{\circ}\text{C}$		-	5.0	-	V
Dynamic	characteristics						
t <sub>rr</sub>	reverse recovery time	$I_{SD}$ = 100 A; $V_{GS}$ = -4 V; di/dt = 6500 A/ $\mu$ s; $V_{R}$ = 600 V; $T_{j}$ = 25 °C		-	23	-	ns
Q <sub>r</sub>	recovered charge			-	950	-	nC
I <sub>rrm</sub>	reverse recovery current			-	72	-	Α
E <sub>rec</sub>	reverse recovery energy			-	370	-	μJ
t <sub>rr</sub>	reverse recovery time	$I_{SD}$ = 100 A; $V_{GS}$ = -4 V; di/dt = 8000 A/ $\mu$ s;		-	30	-	ns
Q <sub>r</sub>	recovered charge	V <sub>R</sub> = 600 V; T <sub>j</sub> = 150 °C		-	2436	-	nC
I <sub>rrm</sub>	reverse recovery current			-	125	-	Α
E <sub>rec</sub>	reverse recovery energy			-	1210	-	μJ
NTC ther	mistor						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R <sub>25</sub>	Rated resistance	T <sub>NTC</sub> = 25 °C		-	5000	-	Ω
R <sub>100</sub>		T <sub>NTC</sub> = 100 °C		465±5%		)	Ω
B <sub>25/50</sub>	B-value	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$		3380			K
	Maximum operating temperature			-	200	-	°C
	Dissipation costant			-	2	-	mW/l
	Thermal time constant			-	≤10	-	s



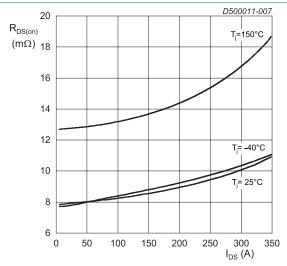
 $T_j$  = -40 °C;  $t_p$  < 200 µs Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



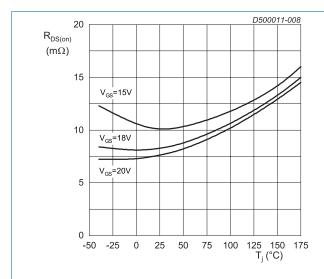
T<sub>j</sub> = 25 °C; t<sub>p</sub> < 200 μs Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



 $T_{j} = 150~^{\circ}\text{C}; \, t_{p} < 200~\mu\text{s}$  Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

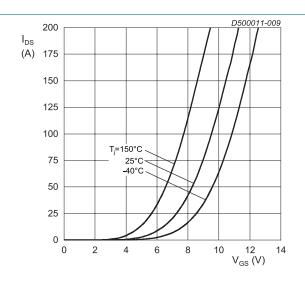


 $V_{GS}$  = 18 V;  $t_p$  < 200 µs Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



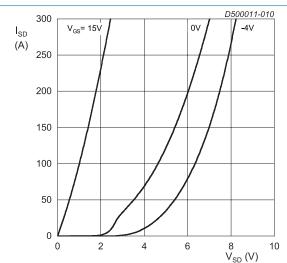
 $I_{DS}$  = 100 A;  $t_p$  < 200  $\mu s$ 

Fig. 8. Drain-source on-state resistance as a function of junction temperature



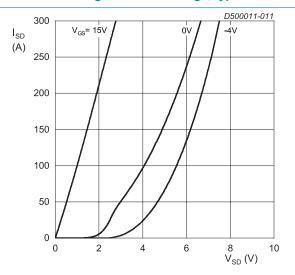
 $V_{DS}$  = 20 V;  $t_p$  < 200 µs

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



 $T_j = -40 \, ^{\circ}\text{C}; \, t_p < 200 \, \mu\text{s}$ 

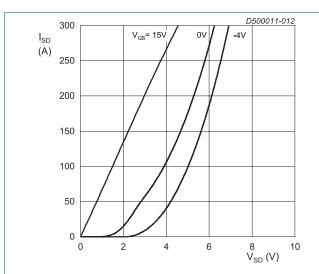
Fig. 10. Body diode forward characteristics; typical values



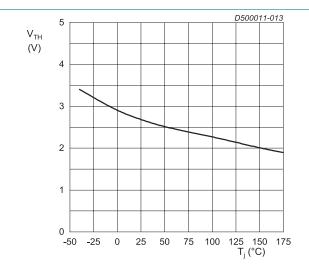
 $T_j = 25 \, ^{\circ}C; t_p < 200 \, \mu s$ 

Fig. 11. Body diode forward characteristics; typical values

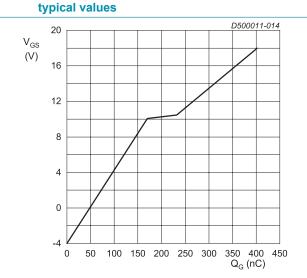
**Product data sheet** 



 $T_{j}$  = 150 °C;  $t_{p}$  < 200 µs Fig. 12. Body diode forward characteristics;



V<sub>DS</sub> = 10 V; I<sub>DS</sub> = 40 mA Fig. 13. Threshold voltage as a function of junction temperature



I<sub>DS</sub> = 100 A; I<sub>GS</sub> = 1 mA; V<sub>DS</sub> = 800 V; T<sub>j</sub> = 25 °C Fig. 14. Gate-source voltage as a function of gate charge; typical values

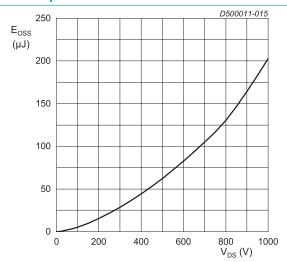
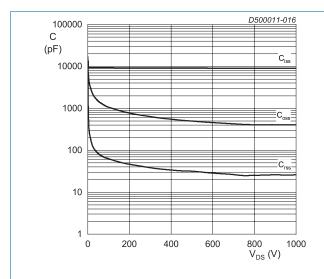
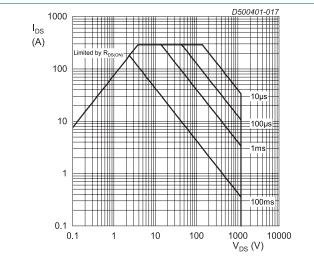


Fig. 15. Output capacitor stored energy as a function of drain-source voltage



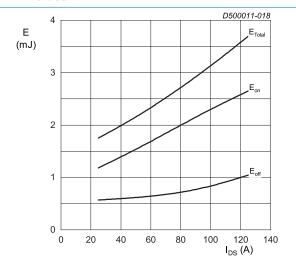
 $V_{DS} = 0 - 1000 V$  $T_i = 25 \text{ °C}; V_{AC} = 25 \text{ mV}; f = 100 \text{ KHz}$ 



 $T_i = 25 \,^{\circ}C; D = 0$ Parameter: t<sub>p</sub>

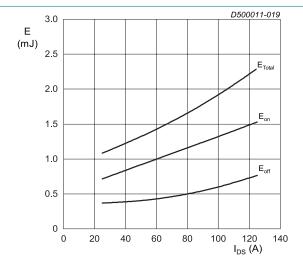
Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

Fig. 17. Forward bias safe operating area



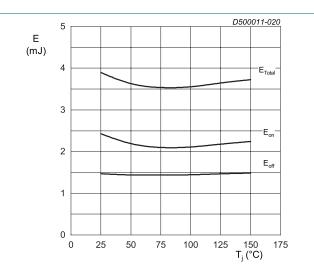
 $T_{j}$  = 25 °C;  $V_{DD}$  = 800 V;  $R_{G(off)}$  = 1.0  $\Omega;$   $R_{G(on)}$  = 1.0  $\Omega;$   $V_{GS}$  = -4 V/18 V; L = 130  $\mu H$ 

Fig. 18. Clamped Inductive Switching Energy as a function of drain current



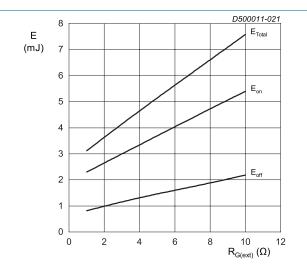
 $T_{j}$  = 25 °C;  $V_{DD}$  = 600 V;  $R_{G(off)}$  = 1.0  $\Omega;$   $R_{G(on)}$  = 1.0  $\Omega;$   $V_{GS}$  = -4 V/18 V; L = 130  $\mu H$ 

Fig. 19. Clamped Inductive Switching Energy as a function of drain current



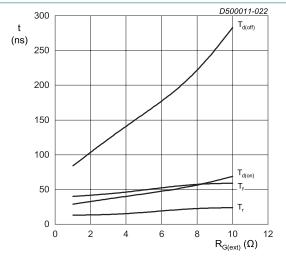
 $I_{DS}$  = 100 A;  $V_{DD}$  = 800 V;  $R_{G(off)}$  = 2.4  $\Omega;$   $R_{G(on)}$  = 2.4  $\Omega;$   $V_{GS}$  = -4 V/18 V; L = 100  $\mu H$ 

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



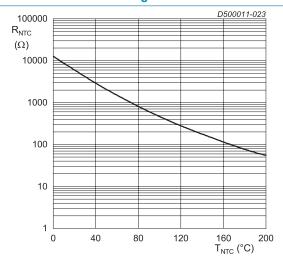
 $T_j = 25 \, ^{\circ}\text{C}; \, V_{DD} = 800 \, \text{V}; \, I_{DS} = 100 \, \text{A}; \, V_{GS} = -4 \, \text{V}/18 \, \text{V};$  $L = 130 \mu H$ 

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



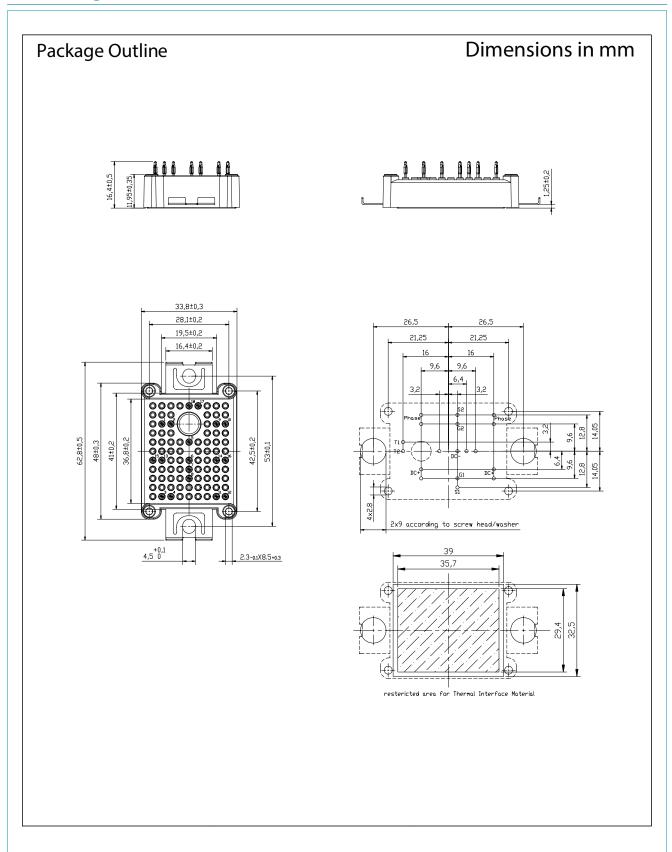
 $T_i = 25$  °C;  $V_{DD} = 800$  V;  $I_{DS} = 100$  A;  $V_{GS} = -4$  V/18 V; Fig. 23. NTC thermistor resistance as a function of  $L = 130 \mu H$ 

Fig. 22. Switching time as a function of external gate resistance



**NTC** temperature

# 11. Package outline



## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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Date of release: 08 April 2025

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